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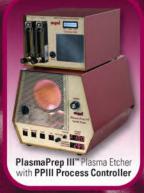
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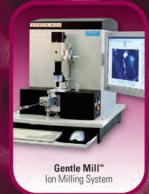
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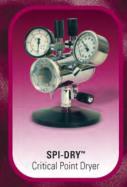














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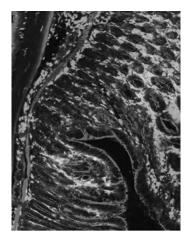
Volume 17, Number 4 August 2011

BIOLOGICAL APPLICATIONS

Collagen Substrates by Rat Cardiac Fibroblasts

Eucalyptus and Pinus radiata Kraft Pulp Fibers Gary Chinga-Carrasco, Yingda Yu, and Ola Diserud

| STEM CELL SPECIAL SECTION  |     |
|--|-----|
| Introduction   |     |
| Introduction to Stem Cell Special Section  Heide Schatten  | 473 |
| Review Article   |     |
| Pluripotent Stem Cells and Reprogrammed Cells in Farm Animals<br>Monika Nowak-Imialek, Wilfried Kues, Joseph W. Carnwath, and Heiner Niemann   | 474 |
| How Can Female Germline Stem Cells Contribute to the Physiological Neo-Oogenesis in Mammals and Why Menopause Occurs?  Antonin Bukovsky  | 498 |
| The Significant Role of Centrosomes in Stem Cell Division and Differentiation  Heide Schatten and Qing-Yuan Sun  | 506 |
| The Hair Follicle Bulge: A Niche for Adult Stem Cells<br>Hilda Amalia Pasolli  | 513 |
| Neural Stem Cells in Neurospheres, Embryoid Bodies, and Central Nervous<br>System of Human Embryos<br>A. Henry Sathananthan  | 520 |
| Cover Article  |     |
| Hematopoietic Derived Cell Infiltration of the Intestinal Tumor Microenvironment in Apc <sup>Min/+</sup> Mice  Celestia Davis, Robert Price, Grishma Acharya, Troy Baudino, Thomas Borg,   | 528 |
| Franklin G. Berger, and Maria Marjorette O. Peña   |     |
| Multiphoton Flow Cytometry to Assess Intrinsic and Extrinsic Fluorescence in Cellular Aggregates: Applications to Stem Cells  David G. Buschke, Jayne M. Squirrell, Hidayath Ansari, Michael A. Smith,  Curtis T. Rueden, Justin C. Williams, Gary E. Lyons, Timothy J. Kamp, Kevin W. Eliceiri,  and Brenda M. Ogle | 540 |



On the Cover: eGFP labeled stem cell progeny in mouse intestinal tumor. For further information see paper by Davis et al. on pages 528-539.

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Age-Dependent Expression of Collagen Receptors and Deformation of Type I

Christopher G. Wilson, John W. Stone, Vennece Fowlkes, Mary O. Morales,

Quantitative Electron Microscopy of Cellulose Nanofibril Structures from

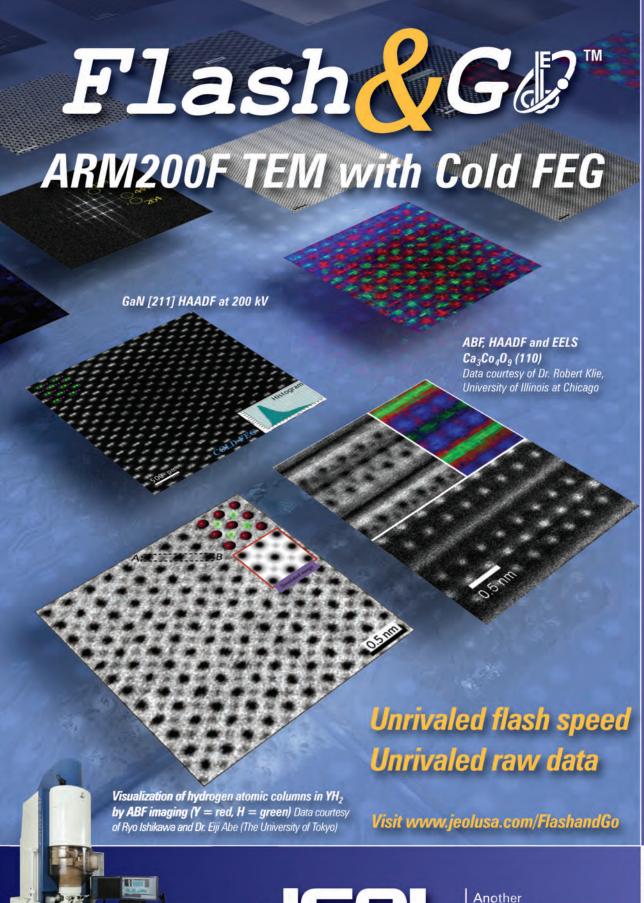
Catherine J. Murphy, Sarah C. Baxter, and Edie C. Goldsmith

555

563

| Karyotype Analysis of Buckwheat Using Atomic Force Microscopy<br>Suresh Neethirajan, Tamaki Hirose, Junichi Wakayama, Kazumi Tsukamoto,<br>Hiroko Kanahara, and Shigeru Sugiyama  | 572 |
|---|-----|
| MATERIALS APPLICATIONS  |     |
| Compositional Analysis with Atomic Column Spatial Resolution by 5th-Order Aberration-Corrected Scanning Transmission Electron Microscopy  David Hernández-Maldonado, Miriam Herrera, Pablo Alonso-González,  Yolanda González, Luisa González, Jaume Gazquez, María Varela, Stephen J. Pennycook,  María de la Paz Guerrero-Lebrero, Joaquín Pizarro, Pedro L. Galindo, and  Sergio I. Molina | 578 |
| Carbon Diffusion from Methane into Walls of Carbon Nanotube through Structurally and Compositionally Modified Iron Catalyst  Michael J. Behr, K. Andre Mkhoyan, and Eray S. Aydil   | 582 |
| Multifrequency Atomic Force Microscopy: Compositional Imaging with Electrostatic Force Measurements Sergei Magonov and John Alexander   | 587 |
| TECHNOLOGY AND SOFTWARE DEVELOPMENT LIGHT AND CONFOCAL MICROSCOPY   |     |
| Quality Assurance Testing for Modern Optical Imaging Systems  | 598 |
| Robert F. Stack, Carol J. Bayles, Anne-Marie Girard, Karen Martin, Cynthia Opansky,<br>Katherine Schulz, and Richard W. Cole  |     |
| Restoration of Uneven Illumination in Light Sheet Microscopy Images<br>Mohammad Shorif Uddin, Hwee Kuan Lee, Stephan Preibisch, and Pavel Tomancak  | 607 |
| Deep Tissue Fluorescent Imaging in Scattering Specimens Using Confocal Microscopy Sherry G. Clendenon, Pamela A. Young, Michael Ferkowicz, Carrie Phillips, and Kenneth W. Dunn   | 614 |
| Measurements Validating the Confocal Scanning Laser Holography Microscope Peter B. Jacquemin and Rodney A. Herring  | 618 |
| HELIUM ION MICROSCOPY   |     |
| Angular Dependence of the Ion-Induced Secondary Electron Emission for He <sup>+</sup> and Ga <sup>+</sup> Beams  Vincenzo Castaldo, Josephus Withagen, Cornelius Hagen, Pieter Kruit, and  Emile van Veldhoven  | 624 |
| Resolution Limits of Secondary Electron Dopant Contrast in Helium Ion and Scanning Electron Microscopy  Mark Jepson, Xiong Liu, David Bell, David Ferranti, Beverley Inkson, and Cornelia Rodenburg   | 637 |
| ls Microanalysis Possible in the Helium Ion Microscope?<br>David C. Joy and Brendan J. Griffin  | 643 |
| BOOK REVIEW   |     |
| Unseen Companions: Big Views of Tiny Creatures<br>Elaine C. Humphrey  | 650 |
| Calendar of Meetings and Courses  | 651 |







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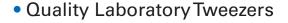


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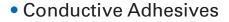
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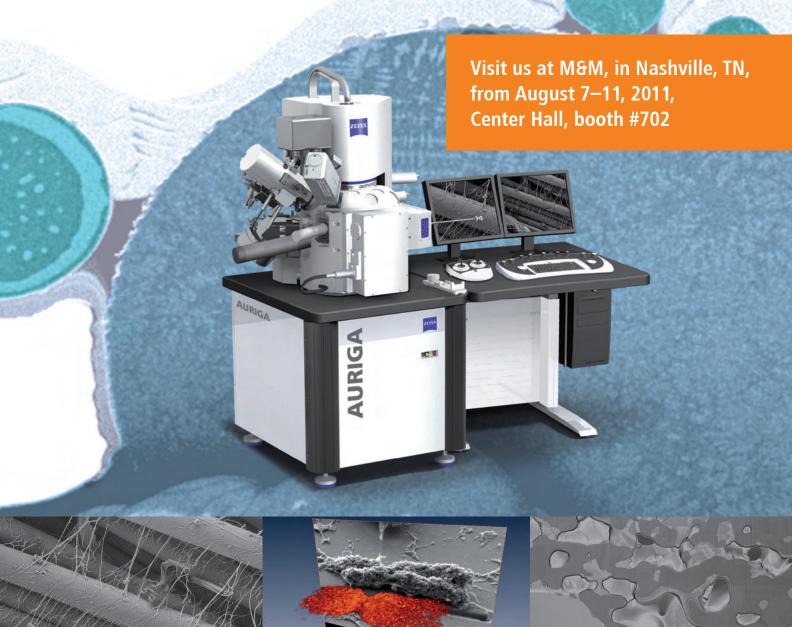
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